

Evaluation of Loss Factor of Multilayered Inhomogeneous Waveguides for Magnetostatic Waves Using Efficient Finite Element Formalism

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Abstract—An efficient finite element solution procedure is developed for calculating propagation losses of magnetostatic waves in multilayered inhomogeneous waveguides. The final matrix equation is reduced to a standard complex eigenvalue problem whose eigenvalue corresponds to the complex phase constant itself. Thus, iteration procedures are not necessary and the phase and attenuation constants can be directly obtained by solving a standard eigenvalue equation. The validity of the method is confirmed by calculating propagation losses of magnetostatic surface waves in a single YIG-film structure. Numerical results for a triple-layered YIG-film structure are also presented. It is found that in the triple-layered structure, propagation losses are highly dependent on the line width of the film in which the magnetostatic potential is well confined.

I. INTRODUCTION

MAGNETOSTATIC wave (MSW) propagation losses for a homogeneous single YIG-film structure have been extensively investigated [1]–[7]. It is known that at high frequencies, a magnetostatic surface wave (MSSW) propagation loss factor L (dB/ μ s) for a single YIG-film structure is proportional to the frequency with a slope of $4\pi(76.4\lambda/\gamma^2\mu_0^2M_s)$ and can be written as $L \approx 76.4\Delta H$ [2]–[5]. Here λ is the damping parameter, M_s is the magnetization, γ is the gyromagnetic ratio, and ΔH is the ferromagnetic resonance line width. It has also been found that magnetostatic forward volume wave (MSFVW) propagation loss characteristics for a single YIG-film structure are similar to MSSW modes and that the dependence of loss factor on line width is also $76.4\Delta H$ [6]. Stancil [7] has investigated propagation losses of MSSW, MSFVW, and magnetostatic backward volume waves (MSBVW) in detail.

Recently, much attention has been paid to MSW modes in various complicated structures such as multilayered and inhomogeneous films to improve the delay characteristics [6], [8]–[10], and numerical approaches such as the variational method [9] and the finite element method [10] have

been introduced for analyzing nonuniform geometries. These methods are valid for the solution of multilayered inhomogeneous waveguiding structures. However, the final matrix equation should be solved by searching for the phase constant such that the determinant of the matrix vanishes. Since the phase constant for lossy waveguides becomes complex, it is very difficult to solve the above matrix equation so as to have the determinant of the complex matrix vanish by searching for two values, i.e., the phase constant and the attenuation constant.

In this paper, an efficient finite element solution procedure is developed for calculating MSW propagation losses for multilayered inhomogeneous waveguides. The final matrix equation is reduced to a standard complex eigenvalue problem whose eigenvalue corresponds to the complex phase constant itself. Thus, iteration procedures are not necessary and the phase and attenuation constants can be directly obtained by solving a standard eigenvalue equation.

The validity of the method is confirmed by calculating MSSW propagation losses for a single YIG-film structure. Also, MSBVW propagation losses for a single YIG-film structure are calculated. It is shown that the MSBVW propagation loss characteristic is similar to that for MSFVW modes. Furthermore, MSFVW propagation losses for a triple-layered YIG-film structure are investigated. It is found that in the triple-layered structure, propagation losses depend greatly on the line width of the film in which the magnetostatic potential is well confined.

II. BASIC EQUATIONS

We consider the multilayered inhomogeneous waveguide for MSW modes shown in Fig. 1. When the bias field H_0 is applied in parallel with the x , y , and z directions, MSFVW, MSBVW, and MSSW modes propagate along the y direction, respectively.

With a time dependence of the form $\exp(j\omega t)$ being implied, the relative permeability tensor $[\mu_r]$ takes the

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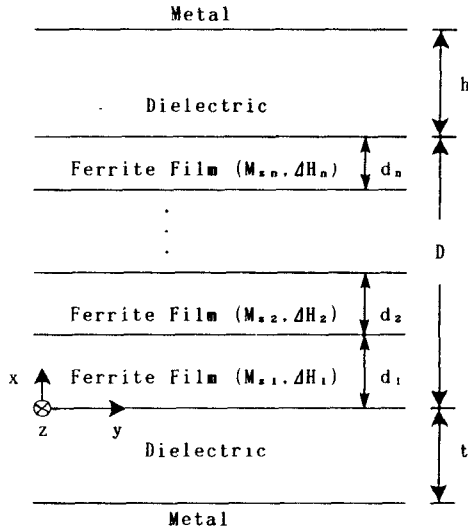


Fig. 1. Geometry of a planar MSW waveguide.

form

$$[\mu_r] = \begin{bmatrix} 1 & 0 & 0 \\ 0 & \mu & j\kappa \\ 0 & -j\kappa & \mu \end{bmatrix} \quad \text{for MSFVW} \quad (1a)$$

$$[\mu_r] = \begin{bmatrix} \mu & 0 & -j\kappa \\ 0 & 1 & 0 \\ j\kappa & 0 & \mu \end{bmatrix} \quad \text{for MSBVW} \quad (1b)$$

$$[\mu_r] = \begin{bmatrix} \mu & j\kappa & 0 \\ -j\kappa & \mu & 0 \\ 0 & 0 & 1 \end{bmatrix} \quad \text{for MSSW} \quad (1c)$$

where

$$\mu = 1 + \frac{\omega_i \omega_m}{\omega_i^2 - \omega^2} \quad (2)$$

$$\kappa = \frac{\omega_m \omega}{\omega_i^2 - \omega^2} \quad (3)$$

$$\omega_i = -\gamma \mu_0 H_i \left(1 + j \frac{\lambda \omega}{\gamma^2 \mu_0^2 H_i M_s} \right) \quad (4)$$

$$\omega_m = -\gamma \mu_0 M_s. \quad (5)$$

Here H_i is the internal magnetic field in the ferrimagnetic film; $H_i = H_0 - M_s$ for MSFVW and $H_i = H_0$ for MSBVW and MSSW. At a given frequency, the damping parameter λ is related to the line width ΔH through the expression [3]

$$\lambda = \frac{\gamma^2 \mu_0^2 M_s}{2\omega} \Delta H \quad (6)$$

and ΔH can be measured from a ferrimagnetic resonance (FMR) absorption.

Assuming that there is no variation of all fields in the z direction, from Maxwell's equations and the magnetostatic approximation condition the following basic equations for MSW waveguides are obtained:

$$\partial B_x / \partial x - jsk B_y = 0 \quad (7)$$

$$H_x = -\partial \phi / \partial x \quad (8)$$

$$H_y = jsk \phi \quad (9)$$

where k is the complex phase constant in the y direction, $\text{Re}(k) \equiv \beta$ and $\text{Im}(k) \equiv -\alpha$ are the phase and attenuation constants, respectively, $s = \pm 1$ is a directional parameter [8], [9], and ϕ is the magnetostatic potential. The time delay T is given by

$$T = \frac{d\beta}{d\omega} \quad (\text{s/m}). \quad (10)$$

The loss factor L in dB/ μ s is defined as

$$L = [8.686\alpha/T] \times 10^{-6} \quad (\text{dB}/\mu\text{s}). \quad (11)$$

III. MATHEMATICAL FORMULATIONS

We consider the following four cases in Fig. 1:

- 1) t and h are finite;
- 2) h is finite and $t \rightarrow \infty$;
- 3) t is finite and $h \rightarrow \infty$;
- 4) $t \rightarrow \infty$ and $h \rightarrow \infty$.

Dividing the region $-t \leq x \leq D+h$, $0 \leq x \leq D+h$, $-t \leq x \leq D$, or $0 \leq x \leq D$ into a number of second-order line elements [11] for case 1), 2), 3), or 4), respectively, using the finite element method based on a Galerkin procedure on (7), integrating by parts, and assembling the complete matrix for the region by adding the contributions of all different elements [10], we obtain

$$k^2 [A] \{\phi\} + k [B] \{\phi\} + [C] \{\phi\} + k \{\tilde{\phi}\} = \{0\} \quad (12)$$

where

$$[A] = \begin{cases} \sum_e \int_{x_1}^{x_2} \mu_e \{N\} \{N\}^T dx & \text{for MSSW and MSFVW} \\ \sum_e \int_{x_1}^{x_2} \{N\} \{N\}^T dx & \text{for MSBVW} \end{cases} \quad (13)$$

$$[B] = \begin{cases} [0] & \text{for MSFVW and MSBVW} \\ s \sum_e \int_{x_1}^{x_2} \kappa_e (\{N_x\} \{N\}^T + \{N\} \{N_x\}^T) dx & \text{for MSSW} \end{cases} \quad (14)$$

$$[C] = \begin{cases} \sum_e \int_{x_1}^{x_2} \mu_e \{N_x\} \{N_x\}^T dx & \text{for MSBVW and MSSW} \\ \sum_e \int_{x_1}^{x_2} \{N_x\} \{N_x\}^T dx & \text{for MSFVW} \end{cases} \quad (15)$$

$$\{\tilde{\phi}\} = \begin{cases} [0 \ 0 \ \dots \ 0 \ 0]^T & \text{for 1)} \\ [\phi_0 \ 0 \ \dots \ 0 \ 0]^T & \text{for 2)} \\ [0 \ 0 \ \dots \ 0 \ \phi_D]^T & \text{for 3)} \\ [\phi_0 \ 0 \ \dots \ 0 \ \phi_D]^T & \text{for 4)}. \end{cases} \quad (16)$$

TABLE I
EXACT AND FINITE ELEMENT SOLUTIONS FOR MSSW MODES IN
A SINGLE YIG-FILM STRUCTURE

f (GHz)	ΔH (Oe)	s	$k = \beta - j\alpha \text{ cm}^{-1}$			
			β_{exact}	$\alpha_{\text{exact}} \times 10^2$	β_{FEM}	$\alpha_{\text{FEM}} \times 10^2$
2.1	0.1	1	12.1316	0.699061	12.1316	0.699053
		-1	26.5995	1.51969	26.5995	1.51969
	0.3	1	12.1316	2.09716	12.1316	2.09716
		-1	26.5995	4.55908	26.5995	4.55908
2.5	0.1	1	206.266	4.28496	206.267	4.28506
		-1	231.271	3.25830	231.271	3.25831
	0.3	1	206.266	12.8549	206.267	12.8552
		-1	231.271	9.77491	231.271	9.77494
3.0	0.1	1	890.659	14.1358	893.671	14.4214
		-1	890.669	14.1351	890.763	14.1417
	0.3	1	890.659	42.4102	893.671	43.2642
		-1	890.699	42.4052	890.763	42.4251

Here T , $\{\cdot\}$, and $\{\cdot\}^T$ denote a transpose, a column vector, and a row vector, respectively. The components of the $\{\phi\}$ vector are the values of ϕ at the nodal points in the region divided into elements; ϕ_0 and ϕ_D are the values of ϕ at the nodal points on $x=0$ and $x=D$, respectively; $\{N\}$ is the shape function vector, $\{N_x\} = d\{N\}/dx$; $\{0\}$ is a null vector; $[0]$ is a null matrix; x_1 and x_2 are the x coordinates of the two ends of the line element ($x_1 < x_2$); and Σ_e extends over all different elements.

In order to obtain directly the complex phase constant k , (12) is reduced to a standard complex eigenvalue equation [11]:

$$\begin{bmatrix} [0] & [U] \\ -[A]^{-1}[C] & -[A]^{-1}[\tilde{B}] \end{bmatrix} \begin{bmatrix} \{\phi\} \\ k\{\phi\} \end{bmatrix} = k \begin{bmatrix} \{\phi\} \\ k\{\phi\} \end{bmatrix} \quad (17)$$

where $[U]$ is a unit matrix and $[\tilde{B}]$ is given by

$$[\tilde{B}] = [B] + [D]. \quad (18)$$

Here

$$[D] = \begin{bmatrix} D_{11} & 0 & \cdots & 0 & 0 \\ 0 & 0 & \cdots & 0 & 0 \\ \vdots & \vdots & \cdots & \vdots & \vdots \\ 0 & 0 & \cdots & 0 & 0 \\ 0 & 0 & \cdots & 0 & D_{nn} \end{bmatrix} \quad (19)$$

$$D_{11}=0 \quad D_{nn}=0 \quad \text{for 1)} \quad (20a)$$

$$D_{11}=1 \quad D_{nn}=0 \quad \text{for 2)} \quad (20b)$$

$$D_{11}=0 \quad D_{nn}=1 \quad \text{for 3)} \quad (20c)$$

$$D_{11}=1 \quad D_{nn}=1 \quad \text{for 4)} \quad (20d)$$

where n corresponds to the number of nodal points. The final matrix equation (17) is a standard eigenvalue problem whose eigenvalue corresponds to the complex phase constant k itself. Thus, iteration procedures are not necessary and the phase and attenuation constants can be directly obtained by solving the standard eigenvalue equation (17).

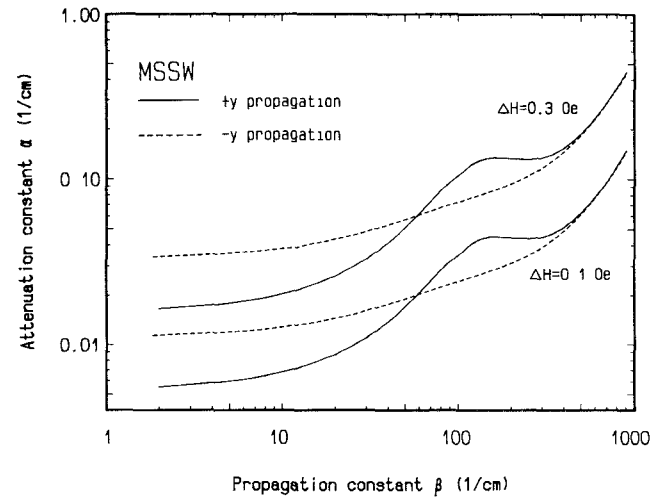


Fig. 2. Attenuation constant as a function of propagation constant for MSSW modes in a single YIG-film structure.

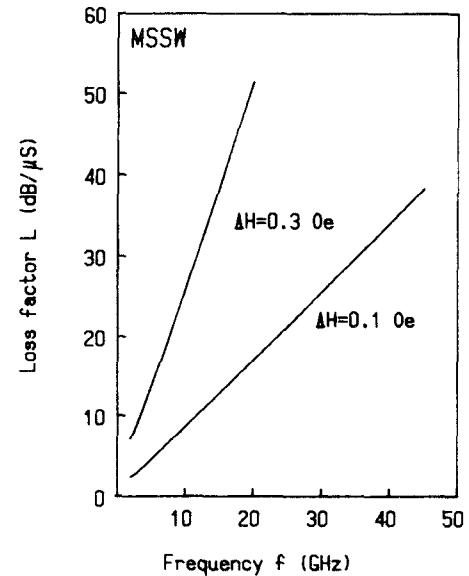


Fig. 3. Frequency dependence of loss factor for MSSW modes in a single YIG-film structure.

IV. COMPUTED RESULTS

As a test for the numerical accuracy of the method proposed here, we first consider a single YIG-film structure [3]. Table I shows the results for MSSW modes where $H_0 = 255$ Oe, $M_s = 1750$ G, $d = 10 \mu\text{m}$, $h = 75 \mu\text{m}$, and $t \rightarrow \infty$; β_{exact} and α_{exact} are the exact solutions [3]; and β_{FEM} and α_{FEM} are the finite element solutions. The number of elements is 9. The damping parameter λ is calculated from an FMR line width of 0.1 and 0.3 Oe at $f = 9.3$ GHz and it is assumed that λ is independent of frequency [3], [5], [6]. Our results agree well with the exact solutions [3] for both phase and attenuation. Fig. 2 shows a plot of α as a function of β . The frequency dependence of the loss factor L is given in Fig. 3. The results in Figs. 2 and 3 are also in agreement with those in [3, figs. 3 and 5], respectively.

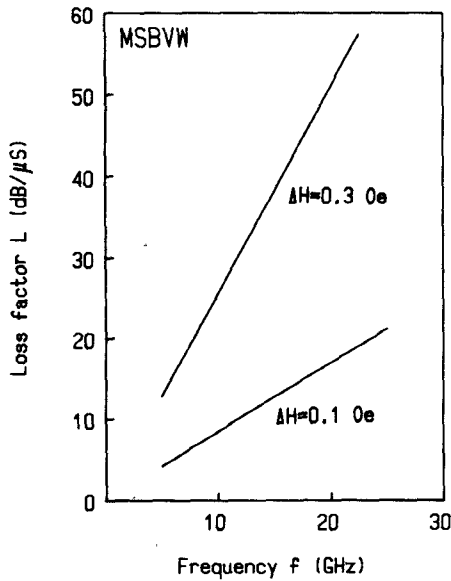
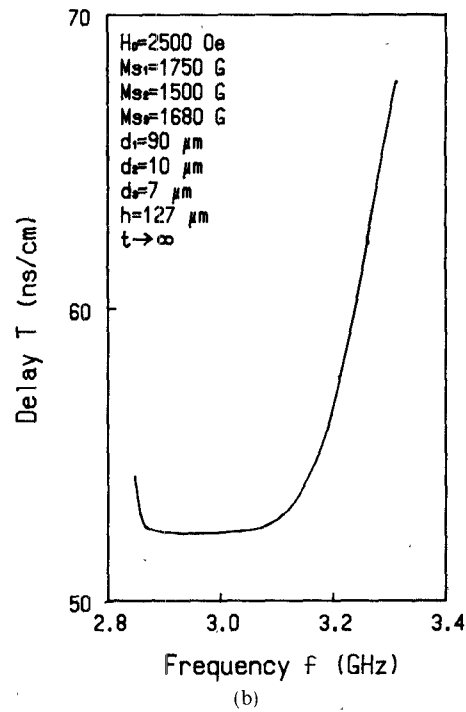
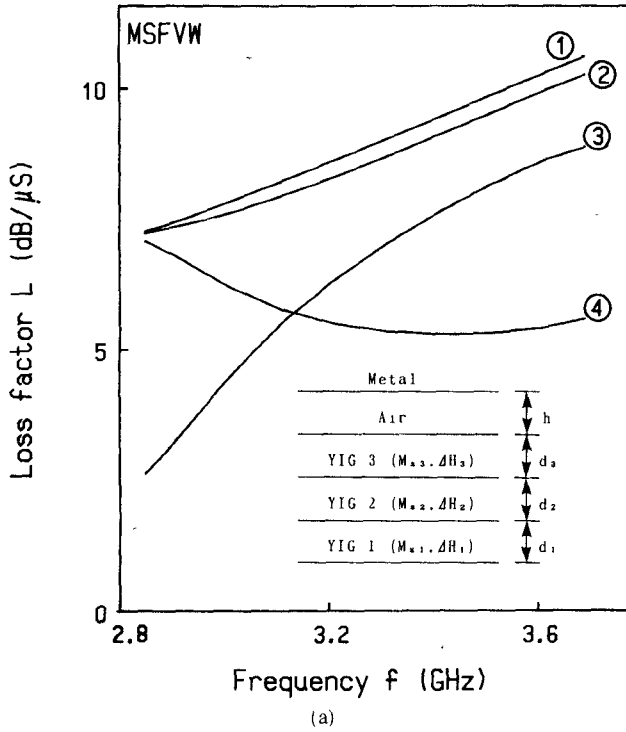


Fig. 4. Frequency dependence of loss factor for MSBVW modes in a single YIG-film structure.



(b)

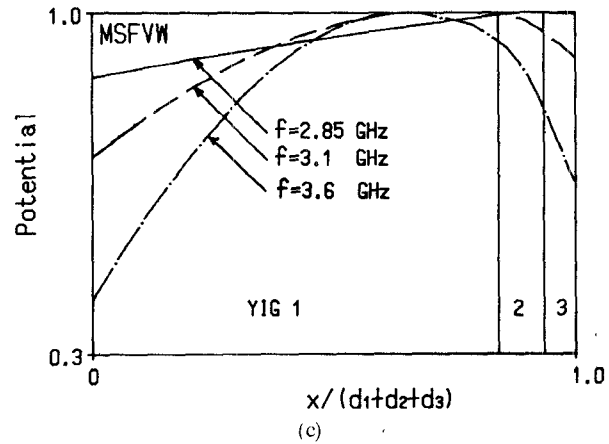


(a)

Fig. 5. MSFVW modes in a triple-layered YIG-film structure. (a) Frequency dependence of loss factor. (Continued in next column)

Next, we consider MSBVW propagation losses for a single YIG-film structure. Fig. 4 shows a plot of the loss factor L as a function of frequency from 5 to 30 GHz, where $M_s = 1200$ G, $d = 30$ μm , $h = 635$ μm , $t \rightarrow \infty$, and $\Delta H = 0.1$ and 0.3 Oe at $f = 9$ GHz. It is shown by Fig. 4 that propagation losses increase rapidly with frequency and that the dependence of the loss factor L on ΔH is also $76.4\Delta H$. This is similar to that for MSFVW modes [6].

Lastly, we consider MSFVW propagation losses for a triple-layered YIG-film structure which have not been



(c)

Fig. 5. (Continued) (b) Group delay. (c) Potential profile.

fully investigated [6], [8]. The frequency dependence of L , the group delay T , and potential profiles are shown in Fig. 5(a), (b), and (c), respectively, where $H_0 = 2500$ Oe, $M_{s1} = 1750$ G, $M_{s2} = 1500$ G, $M_{s3} = 1680$ G, $d_1 = 90$ μm , $d_2 = 10$ μm , $d_3 = 7$ μm , $h = 127$ μm , $t \rightarrow \infty$, and ΔH_1 , ΔH_2 , ΔH_3 , are given by

$$\Delta H_1 = \Delta H_2 = \Delta H_3 = 0.3 \text{ Oe} \quad \text{for } \textcircled{1} \quad (21a)$$

$$\Delta H_3 = 0.1 \text{ Oe} \quad \Delta H_1 = \Delta H_2 = 0.3 \text{ Oe} \quad \text{for } \textcircled{2} \quad (21b)$$

$$\Delta H_2 = 0.1 \text{ Oe} \quad \Delta H_3 = \Delta H_1 = 0.3 \text{ Oe} \quad \text{for } \textcircled{3} \quad (21c)$$

$$\Delta H_1 = 0.1 \text{ Oe} \quad \Delta H_2 = \Delta H_3 = 0.3 \text{ Oe} \quad \text{for } \textcircled{4} \quad (21d)$$

For comparison with the lossless case $\Delta H_1 = \Delta H_2 = \Delta H_3 = 0$ [8], the results above 2.8 GHz are presented in Fig. 5. The delay curve and potential profiles are almost the same for all the cases 1, 2, 3, and 4. Also, the delay curve in Fig. 5(b) is like that in [8, fig. 3]. When three films have the same line width (case 1), the frequency depen-

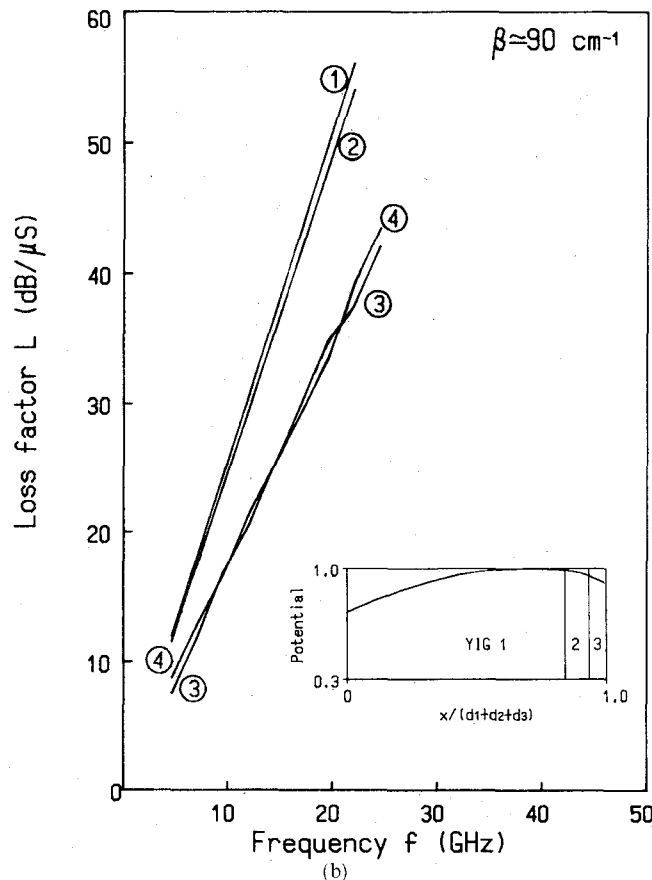
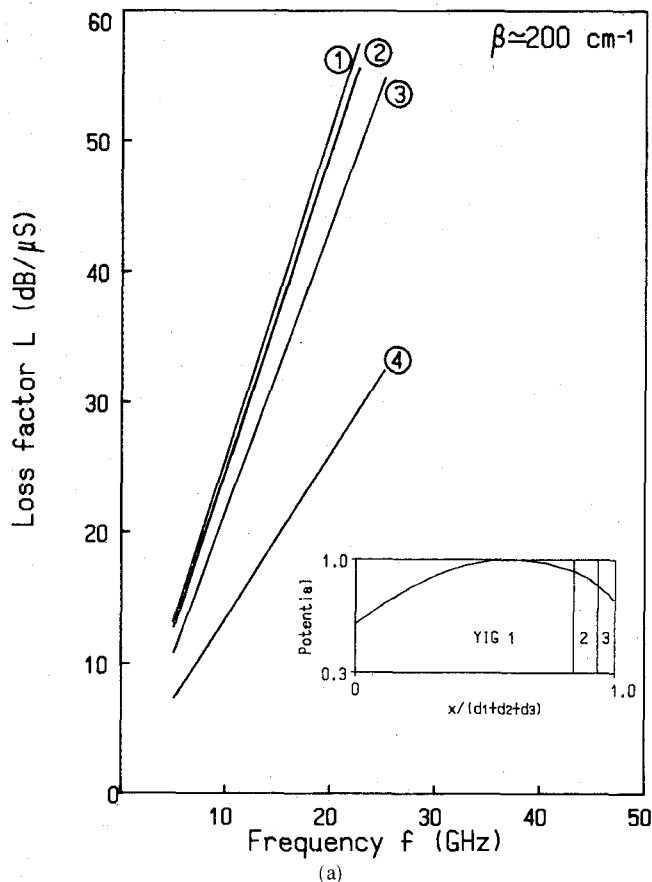


Fig. 6. Frequency dependence of loss factor for MSFVW modes in a triple-layered YIG-film structure. (a) $\beta \approx 200 \text{ cm}^{-1}$. (b) $\beta \approx 90 \text{ cm}^{-1}$.

dence of L is similar to that for a single YIG-film structure. With increasing frequency, the potential is well confined in the first film. Thus, the loss factor L for case 4 with smaller ΔH_1 decreases with frequency. In cases 2 and 3 with larger ΔH_1 , on the other hand, the loss factor L increases with frequency. Since the magnitude of the potential is relatively small in the third film, the influence of the value of ΔH_3 on L is very small and the difference between the loss factors of cases 1 and 2 is small. It is found from Fig. 5(a) and (b) that case 3 provides the smallest propagation loss in nondispersive bandwidth. The frequency dependence of the loss factor for $\beta \approx 200$ and 90 cm^{-1} is shown in Fig. 6(a) and (b), respectively. In order to preserve the constant value of β , the bias field H_0 is altered. When β is approximately constant, potential profiles are almost the same even though frequency varies. In the case of $\beta \approx 200 \text{ cm}^{-1}$, the potential is well confined in the first film. In the case of $\beta \approx 90 \text{ cm}^{-1}$, on the other hand, the potential peak moves toward the interface between the first and second films. It is found from Figs. 5 and 6 that propagation losses depend greatly on the line width of the film in which the potential is well confined.

V. CONCLUSIONS

An efficient finite element solution procedure was developed for the analysis of MSW propagation losses for multilayered inhomogeneous waveguides. The final matrix equation is reduced to a standard complex eigenvalue problem whose eigenvalue corresponds to the complex phase constant itself. Thus, the phase and attenuation constants can be directly obtained by solving a standard eigenvalue equation.

The validity of the method is confirmed by calculating MSSW propagation losses for a single YIG-film structure. Also, MSBVW propagation losses for a single YIG-film structure are calculated. It is shown that the MSBVW propagation loss characteristic is similar to that for MSFVW modes. Furthermore, MSFVW propagation losses for three-layered YIG-film structure are also investigated. It is found that in the triple-layered structure, propagation losses depend greatly on the line width of the film in which the potential is well confined.

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